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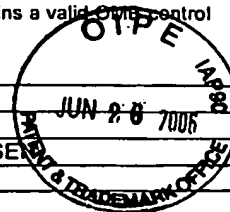
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**INFORMATION DISCLOSURE
STATEMENT BY APPLICANT**

Date Submitted: June 26, 2006

(use as many sheets as necessary)

Complete if Known

Application Number	10/501,010
Filing Date	12/11/2002
First Named Inventor	Per Waaben HANSEN
Group Art Unit	2863
Examiner Name	J. Moffat
Attorney Docket Number	030307-0227



Sheet 1 of 1

U.S. PATENT DOCUMENTS

Examiner Initials*	Cite No. ¹	U.S. Patent Document		Name of Patentee or Applicant of Cited Document	Date of Publication of Cited Document MM-DD-YYYY	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		Number	Kind Code ² (if known)			
JM ↓		6,049,762		Ganz et al.	04-11-2000	
		5,559,728		Kowalski et al.	09-24-1996	
		5,456,677		Spector	10-10-1995	
		5,357,338		Ruhl, Jr. et al	10-18-1994	
		5,252,829		Nygaard et al.	10-12-1993	
		5,121,337		Brown	06-09-1992	
		6,138,082		Wang et al.	10-24-2000	

FOREIGN PATENT DOCUMENTS

Examiner Initials*	Cite No. ¹	Foreign Patent Document			Name of Patentee or Applicant of Cited Documents	Date of Publication of Cited Document MM-DD-YYYY	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	T ⁶
		Office ³	Number ⁴	Kind Code ⁵ (if known)				
JM ↓		EP	0 598 015	B1	Ruhl, Jr.	08-06-1992		
		SE	9203711		Forsblom et al.	filing date 12-09-1992		Yes
		WO	98/43070		Hansen et al.	10-01-1998		
		WO	95/16201		Amvidarson et al.	06-15-1995		
		WO	93/06460		Sjaunja et al.	04-01-1993		

NON PATENT LITERATURE DOCUMENTS

Examiner Initials*	Cite No. ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.) date, page(s), volume-issue number(s), publisher, city and/or country where published.	T ⁶
JM ↓		YONGDONG WANG et al; Improvement of Multivariate Calibration through Instrument Standardization; Anal. Chem.. 1992, 64, 562-564	
		YONGDONG WANG et al; Standardization of Second-Order Instruments; Anal. Chem. 1993, 65, 1174-1180	
		YONDONG WANG et al; Multivariate Instrument Standardization; Anal. Chem. 1991, 63, 2750-2756	
		Partial Least Squares (PLS), StatSoft, Inc.; 08-13-2001; 1-12	

Examiner Signature

/Jonathan Moffat/

Date 07/27/2006
Considered

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¹ Unique citation designation number. ² See attached Kinds of U.S. Patent Documents. ³ Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). ⁴ For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document.

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